

<b>Notice of References Cited</b>	Application/Control No. 10/624,466	Applicant(s)/Patent Under Reexamination HARWELL ET AL.	
	Examiner Sang Y Paik	Art Unit 3742	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,786,799	11-1988	Welle et al.	219/486
	B	US-4,410,795	10-1983	Ueda, Shigeki	219/492
	C	US-			
	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	S					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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